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ON Semiconductor® FDB035AN06A0

N-Channel PowerTrench[®] MOSFET 60 V, 80 A, 3.5 m Ω

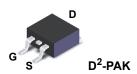
Features

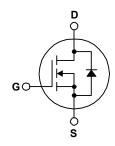
- $R_{DS(on)}$ = 3.2 m Ω (Typ.) @ V_{GS} = 10 V, I_D = 80 A
- $Q_{G(tot)}$ = 95 nC (Typ.) @ V_{GS} = 10 V
- · Low Miller Charge
- Low Q_{rr} Body Diode
- UIS Capability (Single Pulse and Repetitive Pulse)

Formerly developmental type 82584

Applications

- Synchronous Rectification for ATX / Server / Telecom PSU
- · Battery Protection Circuit
- Motor drives and Uninterruptible Power Supplies





MOSFET Maximum Ratings T_C = 25°C unless otherwise noted

Symbol	Parameter	FDB035AN06A0	Unit	
V _{DSS}	Drain to Source Voltage	60	V	
V_{GS}	Gate to Source Voltage	±20	V	
I _D	Drain Current			
	Continuous (T _C < 153°C, V _{GS} = 10V)	80	Α	
	Continuous ($T_{amb} = 25^{\circ}C$, $V_{GS} = 10V$, with $R_{\theta JA} = 43^{\circ}C/W$)	22	А	
	Pulsed	Figure 4	А	
E _{AS}	Single Pulse Avalanche Energy (Note 1)	625	mJ	
P _D	Power dissipation	310	W	
	Derate above 25°C	2.07	W/°C	
T _J , T _{STG}	Operating and Storage Temperature	-55 to 175	°C	

Thermal Characteristics

$R_{\theta JC}$	Thermal Resistance, Junction to Case, Max.	0.48	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient, Max. (Note 2)	62	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient, 1in ² copper pad area, Max.	43	°C/W

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Package Marking and Ordering Information Device Marking Device **Package Reel Size** Tape Width Quantity 330 mm FDB035AN06A0 FDB035AN06A0 D²-PAK 24 mm 800 units **Electrical Characteristics** $T_C = 25^{\circ}C$ unless otherwise noted Symbol **Parameter Test Conditions** Min Тур Max Unit **Off Characteristics** $\mathsf{B}_{\mathsf{VDSS}}$ Drain to Source Breakdown Voltage $I_D = 250 \mu A, V_{GS} = 0 V$ 60 V $V_{DS} = 50V$ 1 _ _ Zero Gate Voltage Drain Current μΑ I_{DSS} $T_C = 150^{\circ}C$ 250 $V_{GS} = 0V$ I_{GSS} Gate to Source Leakage Current $V_{GS} = \pm 20V$ ±100 nΑ On Characteristics Gate to Source Threshold Voltage ٧ $V_{GS(TH)}$ $V_{GS} = V_{DS}, I_{D} = 250 \mu A$ 2 4 $I_D = 80A, V_{GS} = 10V$ 0.0032 0.0035 $I_{D} = 40A, V_{GS} = 6V$ 0.0044 _ 0.0066 Ω r_{DS(ON)} Drain to Source On Resistance $I_D = 80A, V_{GS} = 10V,$ 0.0065 0.0071 $T_{.1} = 175^{\circ}C$ **Dynamic Characteristics** C_{ISS} Input Capacitance -6400 _ pF $V_{DS} = 25V, V_{GS} = 0V,$ Output Capacitance 1123 рF C_{OSS} f = 1MHz Reverse Transfer Capacitance 367 pF C_{RSS} $V_{GS} = 0V to 10V$ Total Gate Charge at 10V 95 124 nC $Q_{g(TOT)}$ Threshold Gate Charge $V_{GS} = 0V \text{ to } 2V$ 12 15 nC $Q_{g(TH)}$ $V_{DD} = 30V$ Gate to Source Gate Charge $I_{D} = 80A$ 30 nC Q_{gs} $I_a = 1.0 \text{mA}$ Q_{gs2} Gate Charge Threshold to Plateau 18 nC Gate to Drain "Miller" Charge 24 Q_{gd} nC **Switching Characteristics** $(V_{GS} = 10V)$ Turn-On Time 163 t_{ON} ns Turn-On Delay Time 15 ns t_{d(ON)} 93 Rise Time _ _ ns $V_{DD} = 30V, I_{D} = 80A$ $V_{GS} = 10V, R_{GS} = 2.4\Omega$ Turn-Off Delay Time 38 ns t_{d(OFF)}

Drain-Source Diode Characteristics

Fall Time

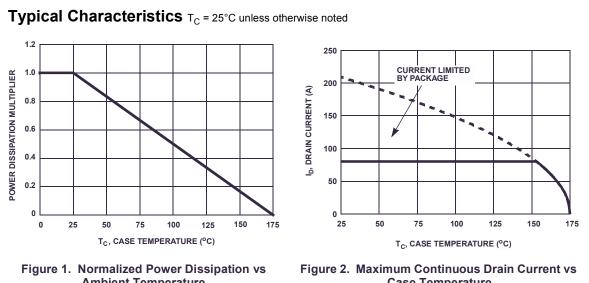
Turn-Off Time

V _{SD}	Source to Drain Diode Voltage	I _{SD} = 80A	-	-	1.25	V
		I _{SD} = 40A	-	-	1.0	V
t _{rr}	Reverse Recovery Time	$I_{SD} = 75A$, $dI_{SD}/dt = 100A/\mu s$	-	-	38	ns
Q _{RR}	Reverse Recovered Charge	$I_{SD} = 75A$, $dI_{SD}/dt = 100A/\mu s$	-	-	39	nC

Notes:

1: Starting T_J = 25°C, L = 0.255mH, I_{AS} = 70A.

2: Pulse Width = 100s



Ambient Temperature

Case Temperature

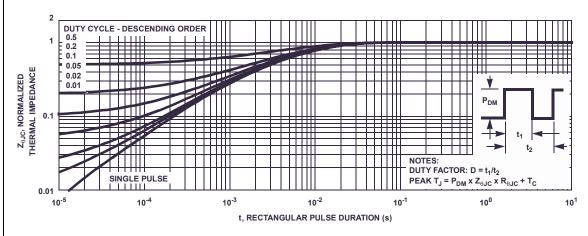


Figure 3. Normalized Maximum Transient Thermal Impedance

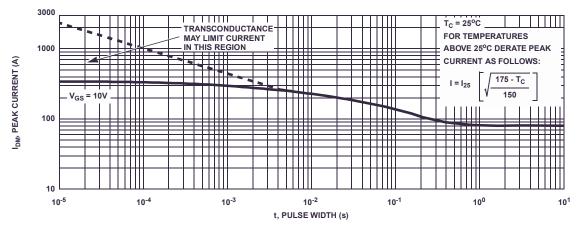


Figure 4. Peak Current Capability

1.5

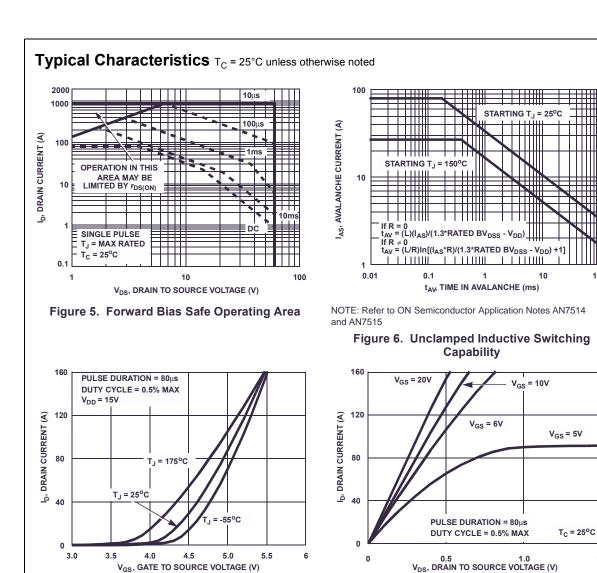


Figure 7. Transfer Characteristics

PULSE DURATION = 80 µS
DUTY CYCLE = 0.5% MAX

V_{GS} = 6V

V_{GS} = 10V

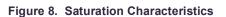
60

Figure 9. Drain to Source On Resistance vs Drain Current

40

I_D, DRAIN CURRENT (A)

20



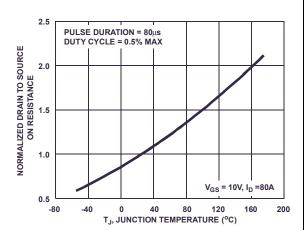


Figure 10. Normalized Drain to Source On Resistance vs Junction Temperature

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80

DRAIN TO SOURCE ON RESISTANCE(m\text{\Omega})

4

Typical Characteristics $T_C = 25^{\circ}C$ unless otherwise noted

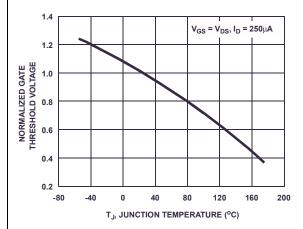


Figure 11. Normalized Gate Threshold Voltage vs Junction Temperature

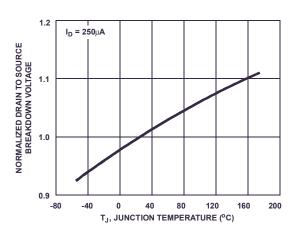


Figure 12. Normalized Drain to Source Breakdown Voltage vs Junction Temperature

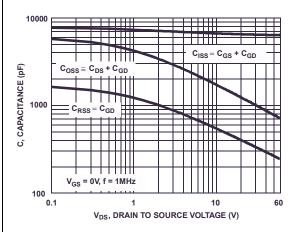


Figure 13. Capacitance vs Drain to Source Voltage

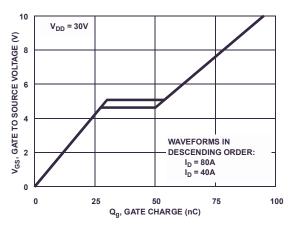


Figure 14. Gate Charge Waveforms for Constant Gate Current

Test Circuits and Waveforms

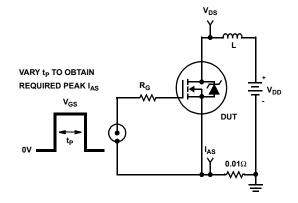


Figure 15. Unclamped Energy Test Circuit

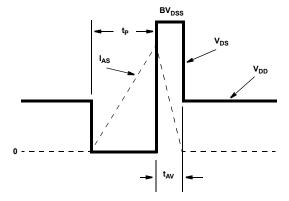


Figure 16. Unclamped Energy Waveforms

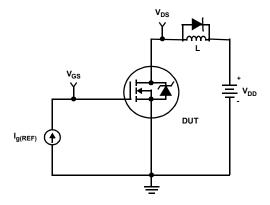


Figure 17. Gate Charge Test Circuit

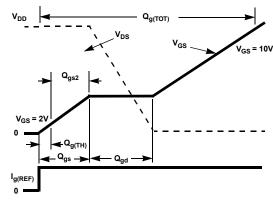


Figure 18. Gate Charge Waveforms

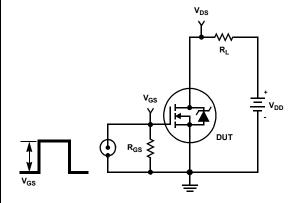


Figure 19. Switching Time Test Circuit

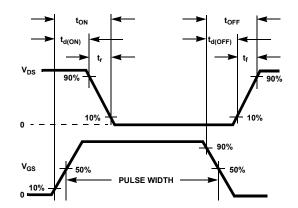


Figure 20. Switching Time Waveforms

Thermal Resistance vs. Mounting Pad Area

The maximum rated junction temperature, T_{JM} , and the thermal resistance of the heat dissipating path determines the maximum allowable device power dissipation, P_{DM} , in an application. Therefore the application's ambient temperature, T_A (°C), and thermal resistance $R_{\theta JA}$ (°C/W) must be reviewed to ensure that T_{JM} is never exceeded. Equation 1 mathematically represents the relationship and serves as the basis for establishing the rating of the part.

$$P_{DM} = \frac{(T_{JM} - T_A)}{R_{\theta JA}} \tag{EQ. 1}$$

In using surface mount devices such as the TO-263 package, the environment in which it is applied will have a significant influence on the part's current and maximum power dissipation ratings. Precise determination of P_{DM} is complex and influenced by many factors:

- Mounting pad area onto which the device is attached and whether there is copper on one side or both sides of the board.
- The number of copper layers and the thickness of the board.
- 3. The use of external heat sinks.
- 4. The use of thermal vias.
- 5. Air flow and board orientation.
- 6. For non steady state applications, the pulse width, the duty cycle and the transient thermal response of the part, the board and the environment they are in.

ON Semiconductor provides thermal information to assist the designer's preliminary application evaluation. Figure 21

defines the $R_{\theta JA}$ for the device as a function of the top copper (component side) area. This is for a horizontally positioned FR-4 board with 1oz copper after 1000 seconds of steady state power with no air flow. This graph provides the necessary information for calculation of the steady state junction temperature or power dissipation. Pulse applications can be evaluated using the ON Semiconductor device Spice thermal model or manually utilizing the normalized maximum transient thermal impedance curve.

Thermal resistances corresponding to other copper areas can be obtained from Figure 21 or by calculation using Equation 2 or 3. Equation 2 is used for copper area defined in inches square and equation 3 is for area in centimeters square. The area, in square inches or square centimeters is the top copper area including the gate and source pads.

$$R_{\theta JA} = 26.51 + \frac{19.84}{(0.262 + Area)}$$
 (EQ. 2)

Area in Inches Squared

$$R_{\theta JA} = 26.51 + \frac{128}{(1.69 + Area)}$$
 (EQ. 3)

Area in Centimeters Squared

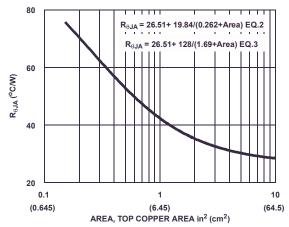
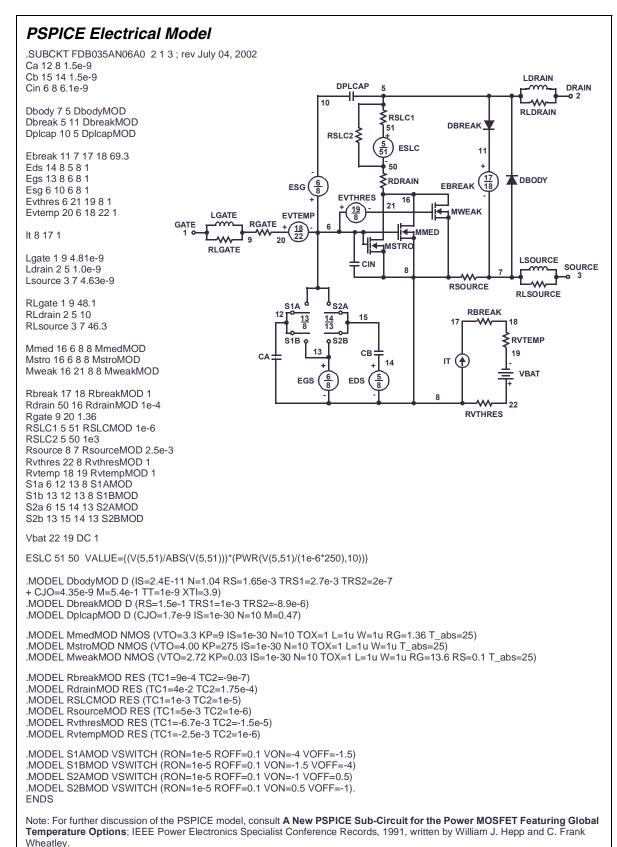


Figure 21. Thermal Resistance vs Mounting
Pad Area



SABER Electrical Model rev July 4, 2002 template FDB035AN06A0 n2,n1,n3 = m_temp electrical n2,n1,n3 number m_temp=25 var i iscl dp..model dbodymod = (isl=2.4e-11,nl=1.04,rs=1.65e-3,trs1=2.7e-3,trs2=2e-7,cjo=4.35e-9,m=5.4e-1,tt=1e-9,xti=3.9) dp..model dbreakmod = (rs=1.5e-1,trs1=1e-3,trs2=-8.9e-6) dp..model dplcapmod = (cjo=1.7e-9,isl=10e-30,nl=10,m=0.47) m..model mmedmod = (type=_n,vto=3.3,kp=9,is=1e-30, tox=1) m..model mstrongmod = $(type=_n, vto=4.00, kp=275, is=1e-30, tox=1)$ LDRAIN m..model mweakmod = (type=_n,vto=2.72,kp=0.03,is=1e-30, tox=1,rs=0.1) DRAIN sw_vcsp..model s1amod = (ron=1e-5,roff=0.1,von=-4,voff=-1.5) sw_vcsp..model s1bmod = (ron=1e-5,roff=0.1,von=-1.5,voff=-4) RLDRAIN sw_vcsp..model s2amod = (ron=1e-5,roff=0.1,von=-1,voff=0.5) RSLC1 sw_vcsp..model s2bmod = (ron=1e-5,roff=0.1,von=0.5,voff=-1) RSLC2 € c.ca n12 n8 = 1.5e-9ISCL c.cb n15 n14 = 1.5e-9c.cin n6 n8 = 6.1e-9DBRFAK RDRAIN dp.dbodv n7 n5 = model=dbodvmod ESG (DBODY dp.dbreak n5 n11 = model=dbreakmod **EVTHRES** dp.dplcap n10 n5 = model=dplcapmod (<u>19</u>) MWEAK **LGATE EVTEMP** RGATE spe.ebreak n11 n7 n17 n18 = 69.3 **EBREAK** MMFD 20 $\frac{1}{100}$ spe.eds n14 n8 n5 n8 = 1 **RLGATE** spe.egs n13 n8 n6 n8 = 1 LSOURCE spe.esg n6 n10 n6 n8 = 1 CIN SOURCE spe.evthres n6 n21 n19 n8 = 1 spe.evtemp n20 n6 n18 n22 = 1 **RSOURCE** RLSOURCE i.it n8 n17 = 1RBREAK 17 I.lgate n1 n9 = 4.81e-9**₹**RVTEMP I.ldrain n2 n5 = 1.0e-9СВ 19 I.lsource n3 n7 = 4.63e-9CA IT (14 **VBAT** res.rlgate n1 n9 = 48.1 EGS res.rldrain n2 n5 = 10res.rlsource n3 n7 = 46.3 **RVTHRES** m.mmed n16 n6 n8 n8 = model=mmedmod, temp=m_temp, l=1u, w=1u m.mstrong n16 n6 n8 n8 = model=mstrongmod, temp=m_temp, l=1u, w=1u m.mweak n16 n21 n8 n8 = model=mweakmod, temp=m_temp, l=1u, w=1u res.rbreak n17 n18 = 1, tc1=9e-4,tc2=-9e-7 res.rdrain n50 n16 = 1e-4, tc1=4e-2,tc2=1.75e-4 res.rgate n9 n20 = 1.36 res.rslc1 n5 n51 = 1e-6, tc1=1e-3,tc2=1e-5 res.rslc2 n5 n50 = 1e3res.rsource n8 n7 = 2.5e-3, tc1=5e-3,tc2=1e-6 res.rvthres n22 n8 = 1, tc1=-6.7e-3,tc2=-1.5e-5 res.rvtemp n18 n19 = 1, tc1=-2.5e-3,tc2=1e-6 sw_vcsp.s1a n6 n12 n13 n8 = model=s1amod sw_vcsp.s1b n13 n12 n13 n8 = model=s1bmod sw_vcsp.s2a n6 n15 n14 n13 = model=s2amod sw_vcsp.s2b n13 n15 n14 n13 = model=s2bmod v.vbat n22 n19 = dc=1 equations { i (n51->n50) +=iscl iscl: v(n51,n50) = ((v(n5,n51)/(1e-9+abs(v(n5,n51))))*((abs(v(n5,n51)*1e6/250))**10))

SPICE Thermal Model

REV 23 July 4, 2002

FDB035AN06A0T

CTHERM1 TH 6 6.45e-3 CTHERM2 6 5 3e-2 CTHERM3 5 4 1.4e-2 CTHERM4 4 3 1.65e-2 CTHERM5 3 2 4.85e-2 CTHERM6 2 TL 1e-1

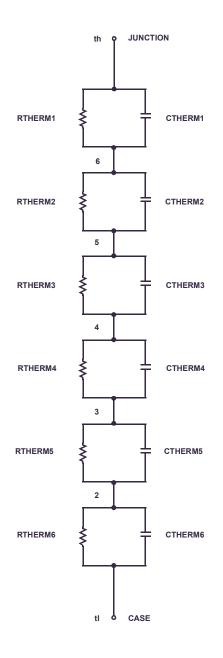
RTHERM1 TH 6 3.24e-3 RTHERM2 6 5 8.08e-3 RTHERM3 5 4 2.28e-2 RTHERM4 4 3 1e-1 RTHERM5 3 2 1.1e-1 RTHERM6 2 TL 1.4e-1

SABER Thermal Model

SABER thermal model FDB035AN06A0T template thermal_model th tl thermal_c th, tl { ctherm.ctherm1 th 6 = 6.45e-3 ctherm.ctherm2 6 5 = 3e-2 ctherm.ctherm3 5 4 = 1.4e-2

ctherm.ctherm2 6 5 = 3e-2 ctherm.ctherm3 5 4 = 1.4e-2 ctherm.ctherm4 4 3 = 1.65e-2 ctherm.ctherm5 3 2 = 4.85e-2 ctherm.ctherm6 2 tl = 1e-1

 $\begin{array}{l} \text{rtherm.rtherm1 th 6 =} 3.24\text{e-}3\\ \text{rtherm.rtherm2 6 5 =} 8.08\text{e-}3\\ \text{rtherm.rtherm3 5 4 =} 2.28\text{e-}2\\ \text{rtherm.rtherm4 4 3 =} 1\text{e-}1\\ \text{rtherm.rtherm5 3 2 =} 1.1\text{e-}1\\ \text{rtherm.rtherm6 2 tl=} 1.4\text{e-}1\\ \end{array}$



Mechanical Dimensions

TO-263 2L (D²PAK)

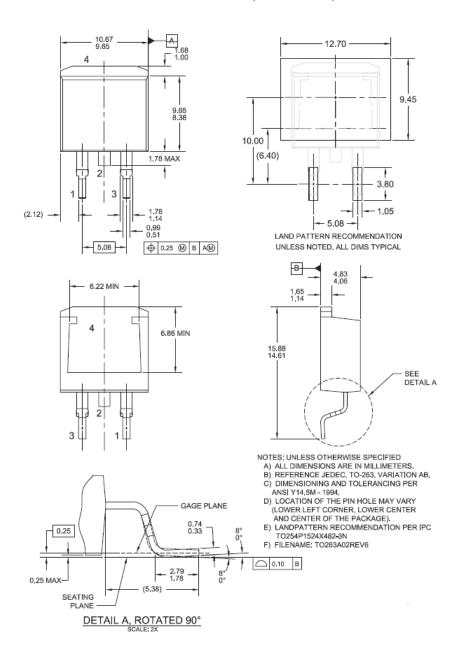


Figure 22. 2LD, TO263, Surface Mount

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